Octal 3-STATE Buffer

MM74HC244

General Description

The MM74HC244 is a non−inverting buffer and has two active low enables ($1\overline{G}$ and $2\overline{G}$); each enable independently controls 4 buffers. This device does not have Schmitt trigger inputs.

These 3−STATE buffers utilize advanced silicon−gate CMOS technology and are general purpose high speed non−inverting buffers. They possess high drive current outputs which enable high speed operation even when driving large bus capacitances. These circuits achieve speeds comparable to low power Schottky devices, while retaining the advantage of CMOS circuitry, i.e., high noise immunity, and low power consumption. All three devices have a fanout of 15 LS−TTL equivalent inputs.

All inputs are protected from damage due to static discharge by diodes to V_{CC} and ground.

Features

- Typical Propagation Delay: 14 ns
- 3−STATE Outputs for Connection to System Buses
- Wide Power Supply Range: 2–6 V
- Low Quiescent Supply Current: 160 μA
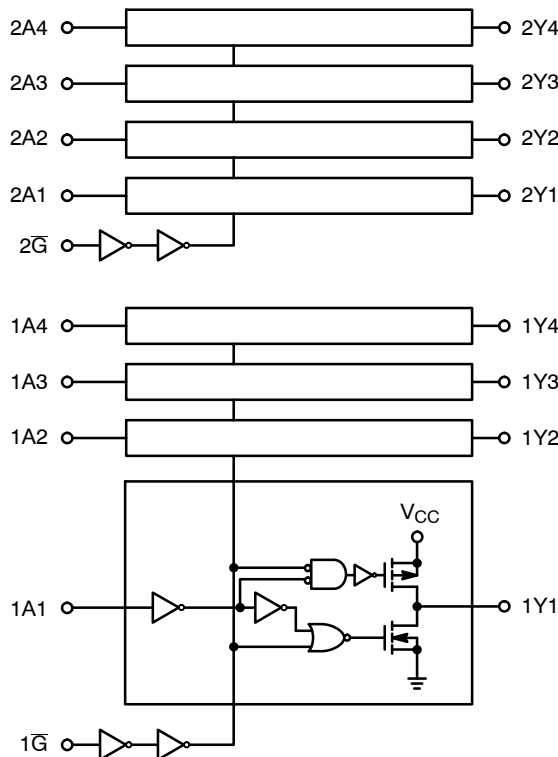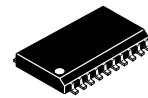- Output Current: 6 mA
- These are Pb−Free Devices

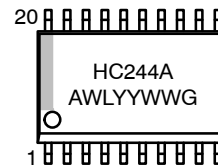**Figure 1. Logic Diagram**

SOIC−20
CASE 751BJ

TSSOP−20
CASE 948AQ

TSSOP−20 WB
CASE 948E

MARKING DIAGRAMS

(SOIC−20)
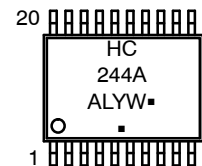
(TSSOP−20,
TSSOP−20WB)

HC240A	= Specific Device Code
A	= Assembly Location
L/WL	= Wafer Lot
Y/YY	= Year
W/WW	= Work Week
▪ or G	= Pb−Free Package

(Note: Microdot may be in either location)

CONNECTION DIAGRAM
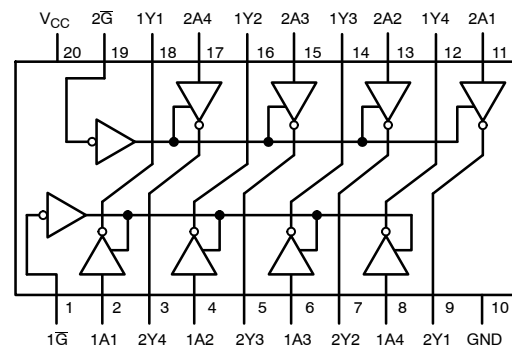
(Top View)

TRUTH TABLE

$1\overline{G}$	1A	1Y	$2\overline{G}$	2A	2Y
L	L	L	L	L	L
L	H	H	L	H	H
H	L	Z	H	L	Z
H	H	Z	H	H	Z

H = HIGH Level
L = LOW Level
Z = HIGH Impedance

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 4 of this data sheet.

Publication Order Number:
MM74HC244/D

MM74HC244

MAXIMUM RATINGS (Note 1)

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	−0.5 to +6.5	V
V_{IN}	DC Input Voltage	−0.5 to V_{CC} + 0.5	V
V_{OUT}	DC Output Voltage	−0.5 to V_{CC} + 0.5	V
I_{IK}, I_{OK}	Clamp Diode Current	±20	mA
I_{OUT}	DC Output Current, per Pin	±35	mA
I_{CC}	DC VCC or GND Current, per Pin	±70	mA
T_{STG}	Storage Temperature Range	−65 to +150	°C
P_D	Power Dissipation SOIC−20W TSSOP−20	1302 833	mW
T_L	Lead Temperature (Soldering 10 seconds)	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Unless otherwise specified all voltages are referenced to ground.

RECOMMENDED OPERATIONG CONDITIONS (Note 1)

Symbol	Parameter	Min	Max	Unit
V_{CC}	Supply Voltage	2	6	V
V_{IN}, V_{OUT}	DC Input or Output Voltage	0	V_{CC}	V
T_A	Operating Temperature Range	−55	+125	°C
t_r, t_f	Input Rise or Fall Times V_{CC} = 2.0 V V_{CC} = 4.5 V V_{CC} = 6.0 V	− − −	1000 500 400	ns

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

DC ELECTRICAL CHARACTERISTICS (Note 2)

Symbol	Parameter	Conditions	V_{CC} (V)	T_A = 25°C Typ	−40°C ≤ T_A ≤ 85°C	−55°C ≤ T_A ≤ 125°C	Unit
					Guaranteed Limits		
V_{IH}	Minimum HIGH Level Input Voltage		2.0 4.5 6.0	− − −	1.5 3.15 4.2	1.5 3.15 4.2	1.5 3.15 4.2	V
V_{IL}	Maximum LOW Level Input Voltage		2.0 4.5 6.0	− − −	0.5 1.35 1.8	0.5 1.35 1.8	0.5 1.35 1.8	V
V_{OH}	Minimum HIGH Level Output Voltage	V_{IN} = V_{IH} or V_{IL} $|I_{OUT}|$ ≤ 20 μA	2.0 4.5 6.0	2.0 4.5 6.0	1.9 4.4 5.9	1.9 4.4 5.9	1.9 4.4 5.9	V
		V_{IN} = V_{IH} or V_{IL} $|I_{OUT}|$ ≤ 6.0 mA $|I_{OUT}|$ ≤ 7.8 mA	4.5 6.0	4.2 5.7	3.98 5.4	3.84 5.34	3.7 5.2	V
V_{OL}	Maximum LOW Level Output Voltage	V_{IN} = V_{IH} or V_{IL} $|I_{OUT}|$ ≤ 20 μA	2.0 4.5 6.0	0 0 0	0.1 0.1 0.1	0.1 0.1 0.1	0.1 0.1 0.1	V
		V_{IN} = V_{IH} or V_{IL} $|I_{OUT}|$ ≤ 6.0 mA $|I_{OUT}|$ ≤ 7.8 mA	4.5 6.0	0.2 0.2	0.26 0.26	0.33 0.33	0.4 0.4	V
I_{IN}	Maximum Input Current	V_{IN} = V_{CC} or GND	6.0	−	±0.1	±1.0	±1.0	μA

DC ELECTRICAL CHARACTERISTICS (Note 2) (continued)

Symbol	Parameter	Conditions	V$_{CC}$ (V)	T$_A$ = 25°C Typ	−40°C ≤ T$_A$ ≤ 85°C	−55°C ≤ T$_A$ ≤ 125°C	Unit
					Guaranteed Limits		
I$_{OZ}$	Maximum 3−STATE Output Leakage Current	V$_{IN}$ = V$_{IH}$ or V$_{IL}$ V$_{OUT}$ = V$_{CC}$ or GND $\overline{G}$ = V$_{IH}$	6.0	−	±0.5	±5	±10	μA
I$_{CC}$	Maximum Quiescent Supply Current	V$_{IN}$ = V$_{CC}$ or GND I$_{OUT}$ = 0 μA	6.0	−	8.0	80	160	μA

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. For a power supply of 5 V ±10% the worst case output voltages (V$_{OH}$, and V$_{OL}$) occur for HC at 4.5 V. Thus the 4.5 V values should be used when designing with this supply. Worst case V$_{IH}$ and V$_{IL}$ occur at V$_{CC}$ = 5.5 V and 4.5 V respectively. (The V$_{IH}$ value at 5.5 V is 3.85 V.) The worst case leakage current (I$_{IN}$, I$_{CC}$, and I$_{OZ}$) occur for CMOS at the higher voltage and so the 6.0 V values should be used.

AC ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Conditions	Typ	Guaranteed Limit	Unit
t$_{PHL}$, t$_{PLH}$	Maximum Propagation Delay	C$_L$ = 45 pF	14	20	ns
t$_{PZH}$, t$_{PZL}$	Maximum Enable Delay to Active Output	R$_L$ = 1 kΩ, C$_L$ = 45 pF	17	28	ns
t$_{PHZ}$, t$_{PLZ}$	Maximum Disable Delay from Active Output	R$_L$ = 1 kΩ, C$_L$ = 5 pF	15	25	ns

AC ELECTRICAL CHARACTERISTICS (V$_{CC}$ = 2.0 V to 6.0 V, C$_L$ = 50 pF, t$_r$ = t$_f$ = 6 ns (unless otherwise specified))

Symbol	Parameter	Conditions	V$_{CC}$ (V)	T$_A$ = 25°C Typ	−40°C ≤ T$_A$ ≤ 85°C	−55°C ≤ T$_A$ ≤ 125°C	Unit
					Guaranteed Limits		
t$_{PHL}$, t$_{PLH}$	Maximum Propagation Delay	C$_L$ = 50 pF C$_L$ = 150 pF	2.0 2.0	58 83	115 165	145 208	171 246	ns
		C$_L$ = 50 pF C$_L$ = 150 pF	4.5 4.5	14 17	23 33	29 42	34 49	ns
		C$_L$ = 50 pF C$_L$ = 150 pF	6.0 6.0	10 14	20 28	25 35	29 42	ns
t$_{PZH}$, t$_{PZL}$	Maximum Output Enable Time	R$_L$ = 1 kΩ C$_L$ = 50 pF C$_L$ = 150 pF	2.0 2.0	75 100	150 200	189 252	224 298	ns
		C$_L$ = 50 pF C$_L$ = 150 pF	4.5 4.5	15 30	30 40	38 50	45 60	ns
		C$_L$ = 50 pF C$_L$ = 150 pF	6.0 6.0	13 17	26 34	32 43	38 51	ns
t$_{PHZ}$, t$_{PLZ}$	Maximum Output Disable Time	R$_L$ = 1 kΩ C$_L$ = 50 pF	2.0 4.5 6.0	75 15 13	150 30 26	189 38 32	224 45 38	ns
t$_{TLH}$, t$_{THL}$	Maximum Output Rise and Fall Time		2.0 4.5 6.0	− − −	60 12 10	75 15 13	90 18 15	ns
C$_{PD}$	Power Dissipation Capacitance (Note 3)	(per buffer) $\overline{G}$ = V$_{IH}$ $\overline{G}$ = V$_{IL}$	− −	12 50	− −	− −	− −	pF
C$_{IN}$	Maximum Input Capacitance		−	5	10	10	10	pF
C$_{OUT}$	Maximum Output Capacitance		−	10	20	20	20	pF

3. C$_{PD}$ determines the no load dynamic power consumption, P$_D$ = C$_{PD}$ · V$_{CC}^2$ · f + I$_{CC}$ · V$_{CC}$, and the no load dynamic current consumption, I$_S$ = C$_{PD}$ · V$_{CC}$ · f + I$_{CC}$.

MM74HC244

ORDERING INFORMATION

Device	Package	Shipping†
MM74HC244WM	SOIC−20 (Pb−Free)	38 Units / Tube
MM74HC244WMX	SOIC−20 (Pb−Free)	1000 / Tape & Reel
MM74HC244MTC	TSSOP−20 WB (Pb−Free)	75 Units / Tube
MM74HC244MTCX	TSSOP−20 (Pb−Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

onsemi

SOIC−20, 300 mils
CASE 751BJ
ISSUE O

DATE 19 DEC 2008
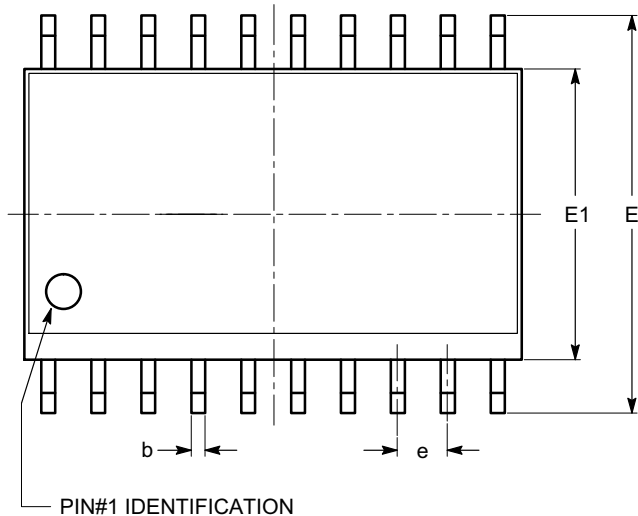
SYMBOL	MIN	NOM	MAX
A	2.36	2.49	2.64
A1	0.10		0.30
A2	2.05		2.55
b	0.31	0.41	0.51
c	0.20	0.27	0.33
D	12.60	12.80	13.00
E	10.01	10.30	10.64
E1	7.40	7.50	7.60
e	1.27 BSC		
h	0.25		0.75
L	0.40	0.81	1.27
θ	0º		8º
θ1	5º		15º
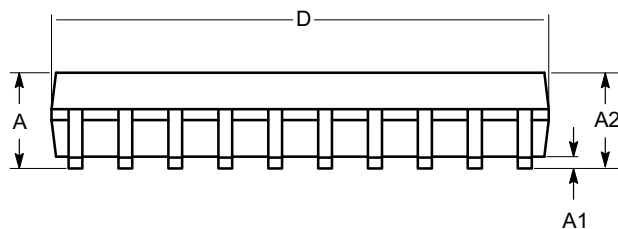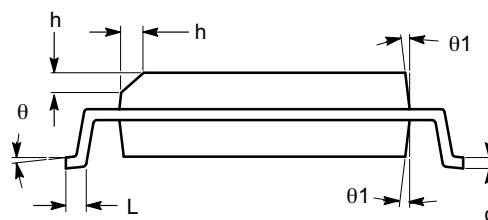
PIN#1 IDENTIFICATION

TOP VIEW

SIDE VIEW

END VIEW

Notes:

(1) All dimensions are in millimeters. Angles in degrees.
(2) Complies with JEDEC MS-013.

DOCUMENT NUMBER:	98AON34287E	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	SOIC−20, 300 MILS		PAGE 1 OF 1

TSSOP−20 WB
CASE 948E
ISSUE D

DATE 17 FEB 2016

SCALE 2:1

0.15 (0.006) | T | U | Ⓢ

20X **K** REF

0.10 (0.004) Ⓜ | T | U | Ⓢ | V | Ⓢ

2X **L/2**

L

PIN 1
IDENT

20   11
B
−U−
10

0.15 (0.006) | T | U | Ⓢ

A
−V−

C

0.100 (0.004)
−T− SEATING PLANE

D   **G**   **H**

K
K1

J **J1**

SECTION N−N

0.25 (0.010)

N

M

N

F

DETAIL E

−W−

DETAIL E
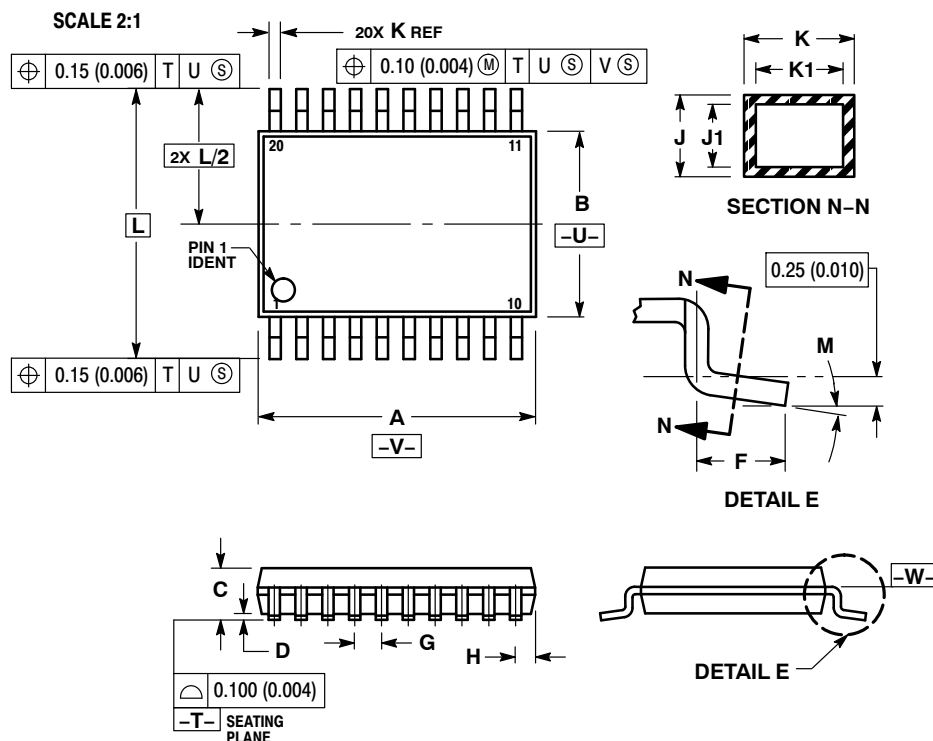
NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE −W−.

DIM	MILLIMETERS MIN	MILLIMETERS MAX	INCHES MIN	INCHES MAX
A	6.40	6.60	0.252	0.260
B	4.30	4.50	0.169	0.177
C	---	1.20	---	0.047
D	0.05	0.15	0.002	0.006
F	0.50	0.75	0.020	0.030
G	0.65 BSC		0.026 BSC	
H	0.27	0.37	0.011	0.015
J	0.09	0.20	0.004	0.008
J1	0.09	0.16	0.004	0.006
K	0.19	0.30	0.007	0.012
K1	0.19	0.25	0.007	0.010
L	6.40 BSC		0.252 BSC	
M	0°	8°	0°	8°

RECOMMENDED
SOLDERING FOOTPRINT*

7.06

1

16X
0.36

16X
1.26

0.65
PITCH

DIMENSIONS: MILLIMETERS

GENERIC
MARKING DIAGRAM*

XXXX
XXXX
ALYW▪
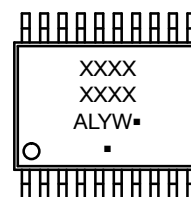
A   = Assembly Location
L   = Wafer Lot
Y   = Year
W   = Work Week
▪   = Pb−Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot " ▪ ", may or may not be present. Some products may not follow the Generic Marking.

*For additional information on our Pb−Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	TSSOP−20 WB		PAGE 1 OF 1

TSSOP20, 4.4x6.5
CASE 948AQ
ISSUE A

DATE 19 MAR 2009
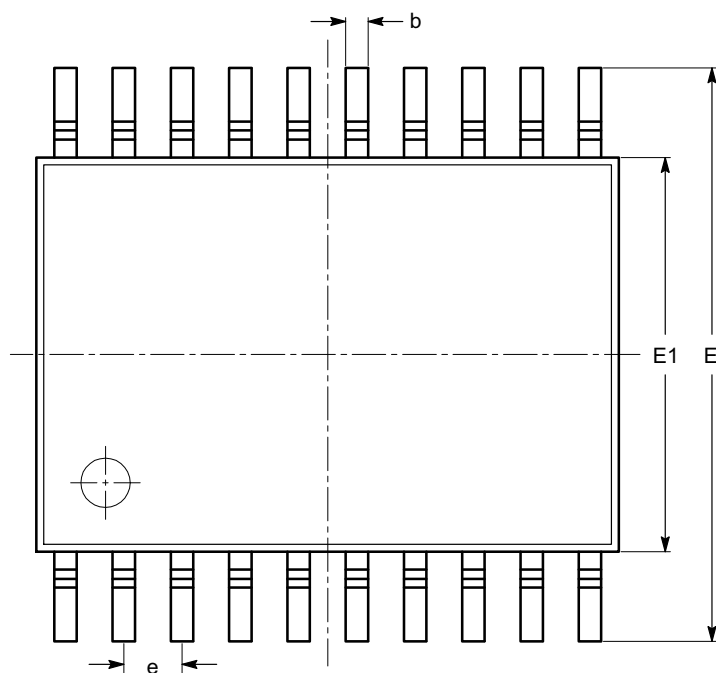
TOP VIEW

SYMBOL	MIN	NOM	MAX
A			1.20
A1	0.05		0.15
A2	0.80		1.05
b	0.19		0.30
c	0.09		0.20
D	6.40	6.50	6.60
E	6.30	6.40	6.50
E1	4.30	4.40	4.50
e		0.65 BSC	
L	0.45	0.60	0.75
L1		1.00 REF	
θ	0º		8º
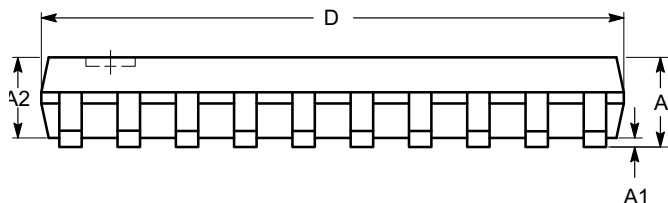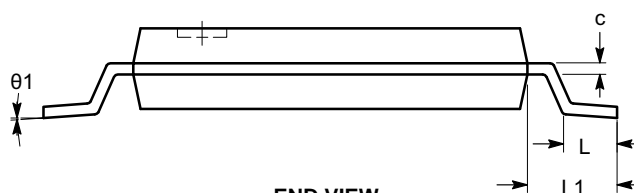
SIDE VIEW

END VIEW

Notes:

(1) All dimensions are in millimeters. Angles in degrees.
(2) Complies with JEDEC MO-153.

DOCUMENT NUMBER:	98AON34453E		
DESCRIPTION:	TSSOP20, 4.4X6.5		PAGE 1 OF 1

ADDITIONAL INFORMATION

◊

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

[onsemi](#):

[MM74HC244MTC](#) [MM74HC244WM](#) [MM74HC244WMX](#) [MM74HC244MTCX](#)